



IEEE

IEC 61636-1

Edition 1.0 2016-11

INTERNATIONAL IEEE Std 1636.1™ STANDARD

**Software interface for maintenance information collection and analysis (SIMICA):
Exchanging test results and session information via the extensible markup
language (XML)**

Withhold

IEC 61636-1 Ed. 1.0 - Preview only Copy via ILNAS e-Shop

IEC 61636-1:2016-11(en) IEEE Std 1636.1-2013



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INTERNATIONAL
ELECTROTECHNICAL
COMMISSION

ICS 25.040.01; 35.060

ISBN 978-2-8322-3684-0

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SOFTWARE INTERFACE FOR MAINTENANCE INFORMATION COLLECTION AND ANALYSIS (SIMICA): EXCHANGING TEST RESULTS AND SESSION INFORMATION VIA THE EXTENSIBLE MARKUP LANGUAGE (XML)

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The text of this standard is based on the following documents:

IEEE Std	FDIS	Report on voting
1636.1 (2013)	91/1360/FDIS	91/1371/RVD

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